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| Notice of References Cited | Application/Control No. 10/068,004 | Applicant(s)/Patent Under Reexamination SO ET AL. | |
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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-2004/0041190 | 03-2004 | Yamazaki et al. | 257/300 |
| * | B | US-2002/0105033 | 08-2002 | ZHANG, HONGYONG | 257/353 |
| * | C | US-5,568,288 | 10-1996 | Yamazaki et al. | 349/42 |
| * | D | US-2003/0207502 | 11-2003 | Yamazaki et al. | 438/149 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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